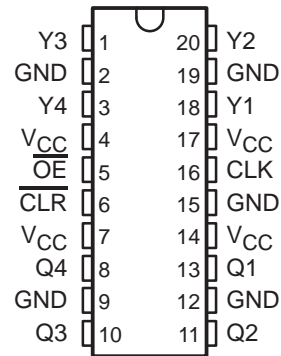


CDC337 CLOCK DRIVER WITH 3-STATE OUTPUTS

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- **Low Output Skew, Low Pulse Skew for Clock-Distribution and Clock-Generation Applications**
- **TTL-Compatible Inputs and CMOS-Compatible Outputs**
- **Distributes One Clock Input to Eight Outputs**
 - Four Same-Frequency Outputs
 - Four Half-Frequency Outputs
- **Distributed V_{CC} and Ground Pins Reduce Switching Noise**
- **High-Drive Outputs ($-48\text{-mA } I_{OH}$, $48\text{-mA } I_{OL}$)**
- **State-of-the-Art EPIC-IIB™ BiCMOS Design Significantly Reduces Power Dissipation**
- **Package Options Include Plastic Small-Outline (DW)**

**DW PACKAGE
(TOP VIEW)**



description

The CDC337 is a high-performance, low-skew clock driver. It is specifically designed for applications requiring synchronized output signals at both the clock frequency and one-half the clock frequency. The four Y outputs switch in phase and at the same frequency as the clock (CLK) input. The four Q outputs switch at one-half the frequency of CLK.

When the output-enable (\overline{OE}) input is low and the clear (\overline{CLR}) input is high, the Y outputs follow CLK and the Q outputs toggle on low-to-high transitions at CLK. Taking \overline{CLR} low asynchronously resets the Q outputs to the low level. When \overline{OE} is high, the outputs are in the high-impedance state.

The CDC337 is characterized for operation from -40°C to 85°C .

FUNCTION TABLE

INPUTS			OUTPUTS	
\overline{OE}	\overline{CLR}	CLK	Y1–Y4	Q1–Q4
H	X	X	Z	Z
L	L	L	L	L
L	L	H	H	L
L	H	L	L	Q_0^{\dagger}
L	H	\uparrow	H	$\overline{Q_0}^{\dagger}$

† The level of the Q outputs before the indicated steady-state input conditions were established



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PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

**TEXAS
INSTRUMENTS**

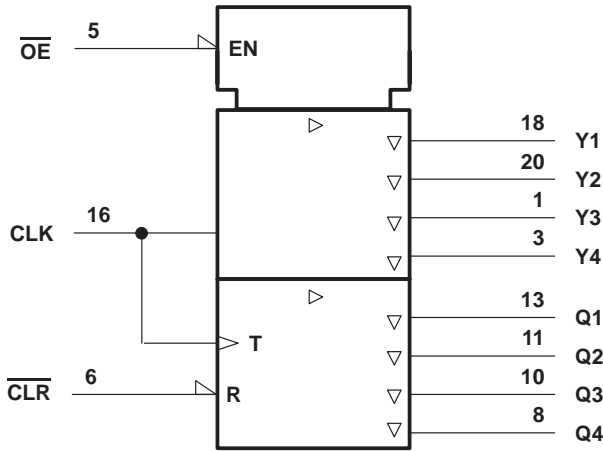
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WITH 3-STATE OUTPUTS

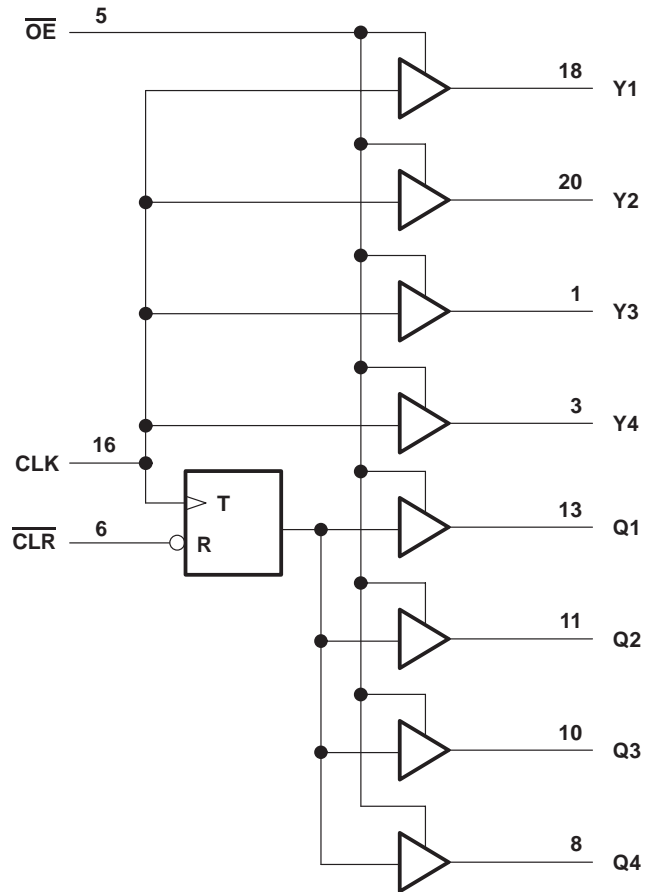
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logic symbol†



† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram (positive logic)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage range, V_{CC}	-0.5 V to 7 V
Input voltage range, V_I (see Note 1)	-0.5 V to 7 V
Voltage range applied to any output in the high state or power-off state, V_O (see Note 1)	-0.5 V to $V_{CC} + 0.5$ V
Current into any output in the low state, I_O	96 mA
Input clamp current, I_{IK} ($V_I < 0$)	-18 mA
Maximum power dissipation at $T_A = 55^\circ\text{C}$ (in still air) (see Note 2)	1.6 W
Storage temperature range, T_{stg}	-65°C to 150°C

‡ Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
 2. The maximum package power dissipation is calculated using a junction temperature of 150°C and a board trace length of 750 mils. For more information, refer to the *Package Thermal Considerations* application note in the 1994 *ABT Advanced BiCMOS Technology Data Book*, literature number SCBD002B.

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recommended operating conditions (see Note 3)

		MIN	MAX	UNIT
V_{CC}	Supply voltage	4.75	5.25	V
V_{IH}	High-level input voltage	2		V
V_{IL}	Low-level input voltage		0.8	V
V_I	Input voltage	0	V_{CC}	V
I_{OH}	High-level output current		-48	mA
I_{OL}	Low-level output current		48	mA
f_{clock}	Input clock frequency		80	MHz
T_A	Operating free-air temperature	-40	85	°C

NOTE 3: Unused pins (input or I/O) must be held high or low to prevent them from floating.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		MIN	TYP†	MAX	UNIT
V_{IK}	$V_{CC} = 4.75\text{ V}$,	$I_I = -18\text{ mA}$			-1.2	V
V_{OH}	$V_{CC} = 4.75\text{ V}$,	$I_{OH} = -32\text{ mA}$	3.75			V
V_{OL}	$V_{CC} = 4.75\text{ V}$,	$I_{OL} = 32\text{ mA}$			0.55	V
I_{IH}	$V_{CC} = 5.25\text{ V}$,	$V_I = 2.7\text{ V}$			50	μA
I_{IL}	$V_{CC} = 5.25\text{ V}$,	$V_I = 0.5\text{ V}$			-50	μA
I_{OZ}	$V_{CC} = 5.25\text{ V}$,	$V_O = V_{CC}$ or GND			±50	μA
I_{CC}	$V_{CC} = 5.25\text{ V}$,	$V_I = V_{CC}$ or GND, $I_O = 0$	Outputs high		70	mA
			Outputs low		85	
			Outputs disabled		70	
C_i	$V_I = 2.5\text{ V}$ or 0.5 V			3		pF
C_o	$V_O = V_{CC}$ or GND			10		pF

† All typical values are at $V_{CC} = 5\text{ V}$, $T_A = 25^\circ\text{C}$.

timing requirements over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

		MIN	MAX	UNIT
f_{clock}	Clock frequency		80	MHz
t_w	Pulse duration	$\overline{\text{CLR}}$ low	4	ns
		CLK low	4	
		CLK high	4	
t_{su}	Setup time, $\overline{\text{CLR}}$ inactive before $\text{CLK}\uparrow$	2		ns
	Clock duty cycle	40%	60%	



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switching characteristics over recommended ranges of supply voltage and operating free-air temperature, $C_L = 50$ pF (unless otherwise noted) (see Note 4 and Figures 1 and 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	MIN	TYP†	MAX	UNIT
f_{max}			80			MHz
t_{PLH}	CLK	Any Y or Q	4		9	ns
t_{PHL}			4		9	
t_{PHL}	\overline{CLR}	Any Q	4		10	ns
t_{PZH}	\overline{OE}	Any Y or Q	3		7	ns
t_{PZL}			3		7	
t_{PHZ}	\overline{OE}	Any Y or Q	2		7	ns
t_{PLZ}			2		7	
$t_{sk(o)}$	CLK↑	Y↑			0.75	ns
		Q↑			0.9	
		Y↑ and Q↑			0.9	
t_r				0.9		ns
t_f				0.7		ns

† All typical values are at $V_{CC} = 5$ V, $T_A = 25^\circ\text{C}$.

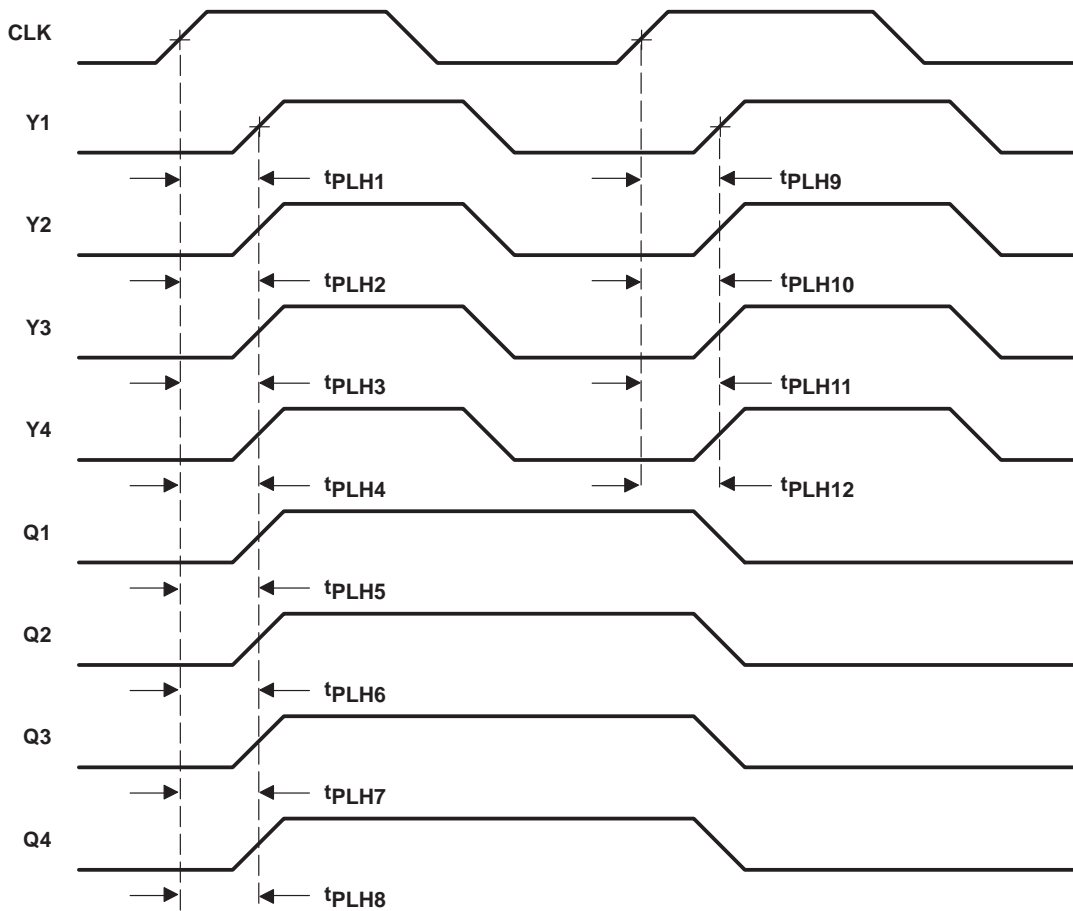
NOTE 4: All specifications are valid only for all outputs switching.



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CLOCK DRIVER
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PARAMETER MEASUREMENT INFORMATION



- NOTES: A. Output skew, $t_{sk(o)}$, from $CLK\uparrow$ to $Y\uparrow$, is calculated as the greater of the difference between the fastest and slowest of t_{PLHn} ($n = 1, 2, 3, 4$) or t_{PLHn} ($n = 9, 10, 11, 12$).
- B. Output skew, $t_{sk(o)}$, from $CLK\uparrow$ to $Q\uparrow$, is calculated as the greater of the difference between the fastest and slowest of t_{PLHn} ($n = 5, 6, 7, 8$).
- C. Output skew, $t_{sk(o)}$, from $CLK\uparrow$ to $Y\uparrow$ and $Q\uparrow$, is calculated as the greater of the difference between the fastest and slowest of t_{PLHn} ($n = 1, 2, \dots, 8$).

Figure 2. Waveforms for Calculation of $t_{sk(o)}$

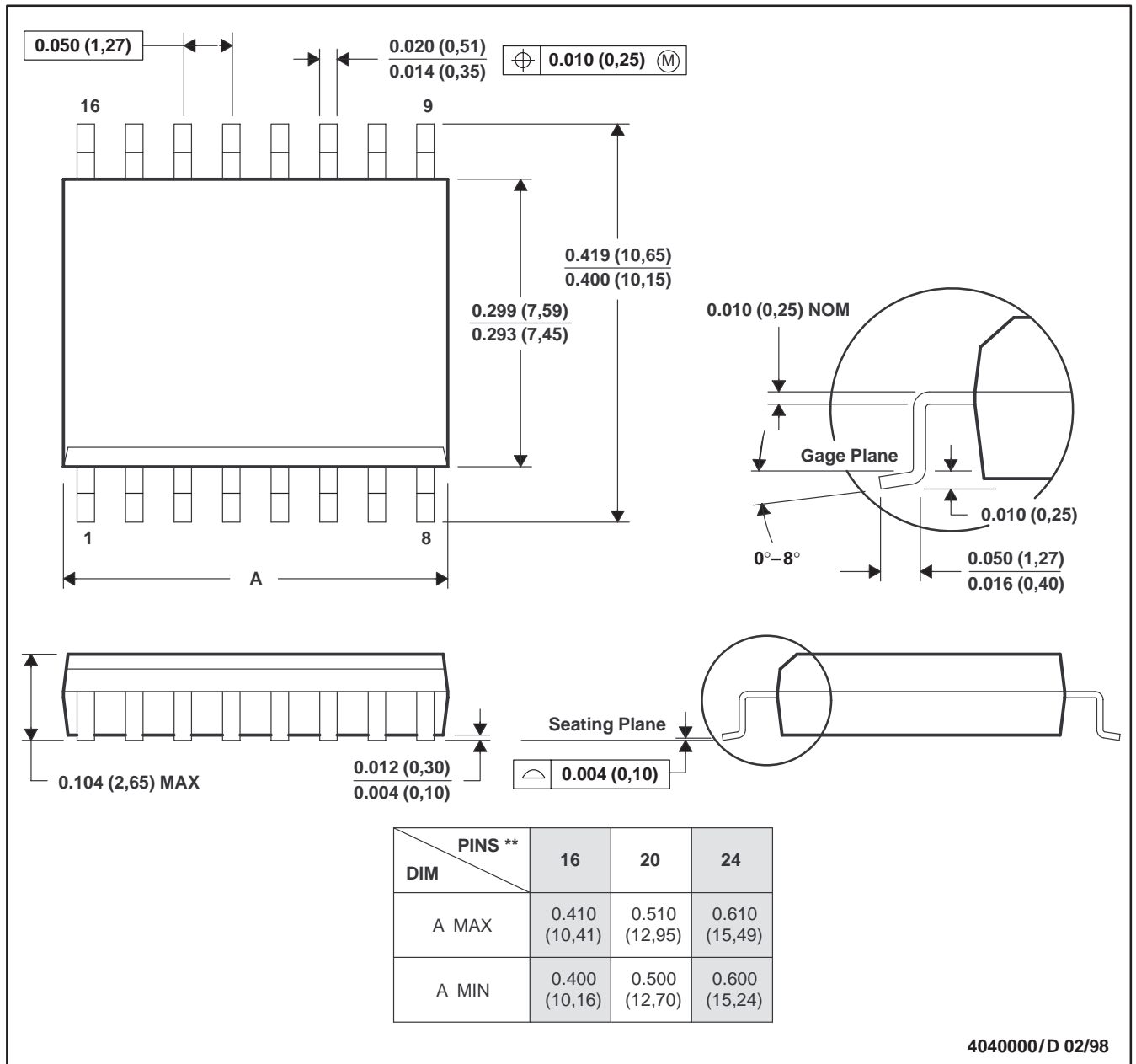


MECHANICAL INFORMATION

DW (R-PDSO-G**)

PLASTIC SMALL-OUTLINE PACKAGE

16 PIN SHOWN



- NOTES: A. All linear dimensions are in inches (millimeters).
 B. This drawing is subject to change without notice.
 C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
 D. Falls within JEDEC MS-013

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